

MRF435



MOTOROLA

The RF Line

NPN SILICON RF POWER TRANSISTOR

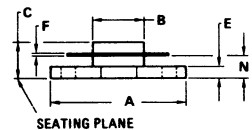
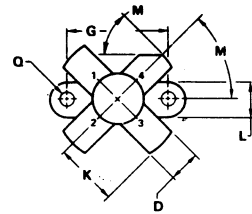
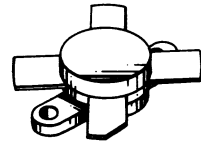
... designed primarily for high-voltage applications as a high-power linear amplifier from 2.0 to 30 MHz. Ideal for marine and base station equipment.

- Specified 28 Volt, 30 MHz Characteristics
Output Power = 150 W
Minimum Gain = 10 dB
Efficiency = 40%
- Intermodulation Distortion @ 150 W(PEP) —
IMD = -30 dB (Max)
- Diffused Emitter Resistors for Superior Ruggedness
- 100% Tested for Load Mismatch at all Phase Angles with 30:1 VSWR @ 150 W CW

150 W (LINEAR) 30 MHz

RF POWER TRANSISTOR

NPN SILICON



STYLE 1:

- PIN 1. EMITTER
- BASE
- EMITTER
- COLLECTOR

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector-Emitter Voltage	V _{CEO}	30	V _{dc}
Collector-Base Voltage	V _{CBO}	60	V _{dc}
Emitter-Base Voltage	V _{EBO}	4.0	V _{dc}
Collector Current — Continuous	I _C	16	A _{dc}
Withstand Current — 10 s	—	20	A _{dc}
Total Device Dissipation @ T _C = 25°C Derate Above 25°C	P _D	320 1.33	Watts W/°C
Storage Temperature Range	T _{stg}	-65 to +200	°C

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case	R _{θJC}	0.75	°C/W

DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	24.38	25.15	0.960	0.990
B	11.81	12.95	0.465	0.510
C	5.82	6.98	0.229	0.275
D	5.46	5.97	0.216	0.235
E	2.13	2.79	0.084	0.110
F	0.08	0.18	0.003	0.007
G	18.29	18.54	0.720	0.730
K	11.05	—	0.435	—
L	6.22	6.48	0.246	0.255
M	45 ⁹ NDM	45 ⁹ NDM	—	—
N	3.66	4.52	0.144	0.178
Q	2.92	3.30	0.115	0.130

CASE 211-11

ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
OFF CHARACTERISTICS					
Collector-Emitter Breakdown Voltage ($I_C = 200\text{ mA dc}$, $I_B = 0$)	$V_{(BR)CEO}$	30	—	—	Vdc
Collector-Emitter Breakdown Voltage ($I_C = 100\text{ mA dc}$, $V_{BE} = 0$)	$V_{(BR)CES}$	60	—	—	Vdc
Collector-Base Breakdown Voltage ($I_C = 100\text{ mA dc}$, $I_E = 0$)	$V_{(BR)CBO}$	60	—	—	Vdc
Emitter-Base Breakdown Voltage ($I_E = 10\text{ mA dc}$, $I_C = 0$)	$V_{(BR)EBO}$	4.0	—	—	Vdc
ON CHARACTERISTICS					
DC Current Gain ($I_C = 5.0\text{ mA dc}$, $V_{CE} = 5.0\text{ Vdc}$)	h_{FE}	15	35	80	—
DYNAMIC CHARACTERISTICS					
Output Capacitance ($V_{CB} = 28\text{ Vdc}$, $I_E = 0$, $f = 1.0\text{ MHz}$)	C_{ob}	—	350	450	pF
FUNCTIONAL TEST					
Common-Emitter Amplifier Gain ($V_{CC} = 28\text{ Vdc}$, $P_{out} = 150\text{ W (PEP)}$, $I_C(\text{max}) = 6.7\text{ A dc}$, $f = 30, 30.001\text{ MHz}$)	G_{PE}	10	13	—	dB
Collector Efficiency ($V_{CC} = 28\text{ Vdc}$, $P_{out} = 150\text{ W (PEP)}$, $I_C(\text{max}) = 6.7\text{ A dc}$, $f = 30, 30.001\text{ MHz}$)	η	40	—	—	%
Intermodulation Distortion (1) ($V_{CE} = 28\text{ Vdc}$, $P_{out} = 150\text{ W (PEP)}$)	IMD	—	-33	-30	dB
Electrical Ruggedness ($V_{CC} = 28\text{ Vdc}$, $P_{out} = 150\text{ W CW}$, $f = 30\text{ MHz}$, VSWR 30:1 at all Phase Angles)	No Degradation in Output Power				

4.1

(1) To Mil Std 1311 Version A, Test Method 2204B, Two Tone, Reference Each Tone.

FIGURE 1 — 30 MHz TEST CIRCUIT SCHEMATIC

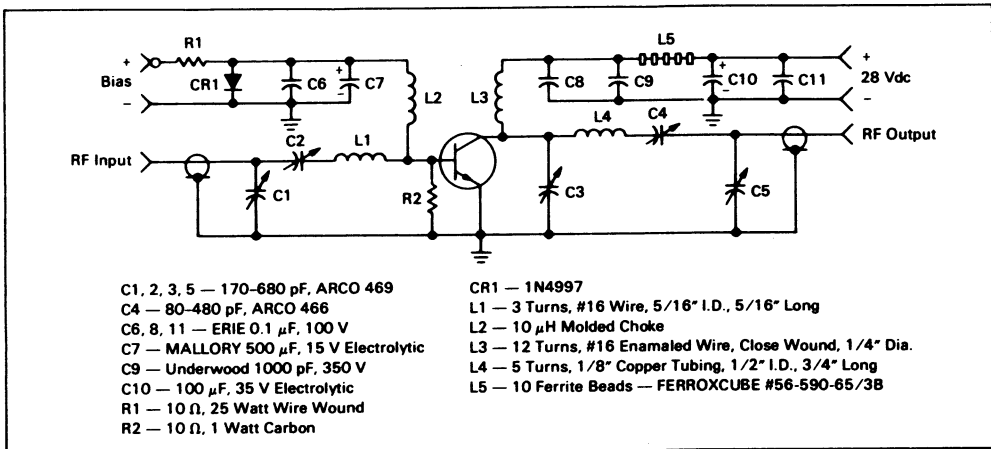


FIGURE 2 — OUTPUT POWER versus INPUT POWER

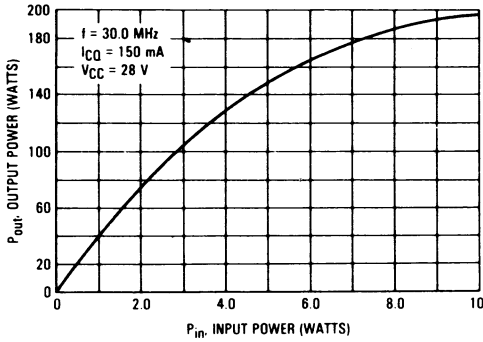


FIGURE 4 — OUTPUT POWER versus SUPPLY VOLTAGE

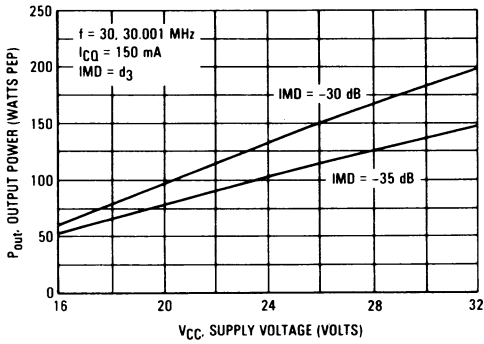


FIGURE 6 — RF SOAR (CLASS AB) P_{out} versus OUTPUT VSWR

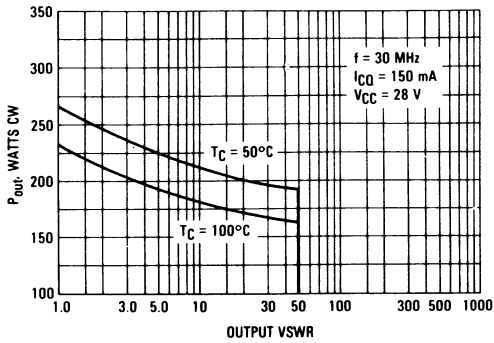


FIGURE 3 — POWER GAIN versus FREQUENCY

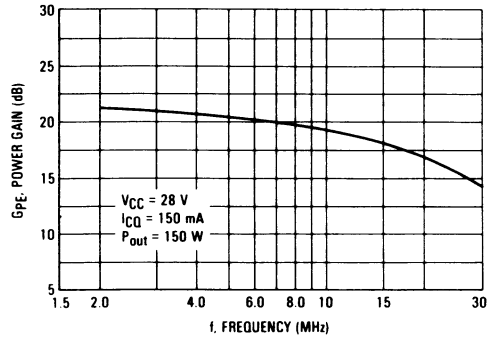


FIGURE 5 — IMD versus P_{out}

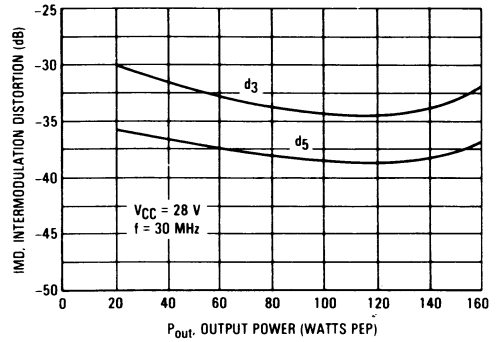
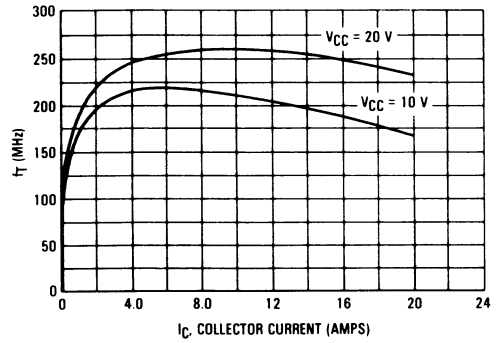


FIGURE 7 — f_T versus COLLECTOR CURRENT



4.1

FIGURE 8 — OUTPUT RESISTANCE versus FREQUENCY

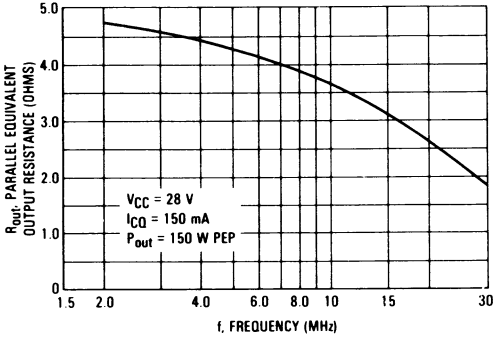


FIGURE 9 — OUTPUT CAPACITANCE versus FREQUENCY

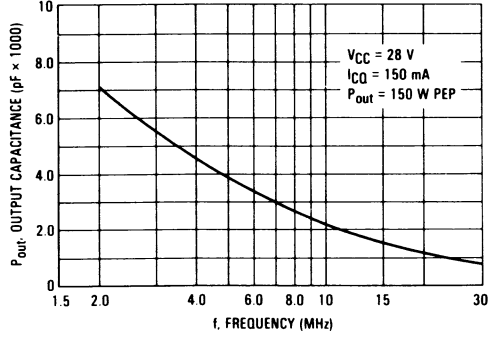
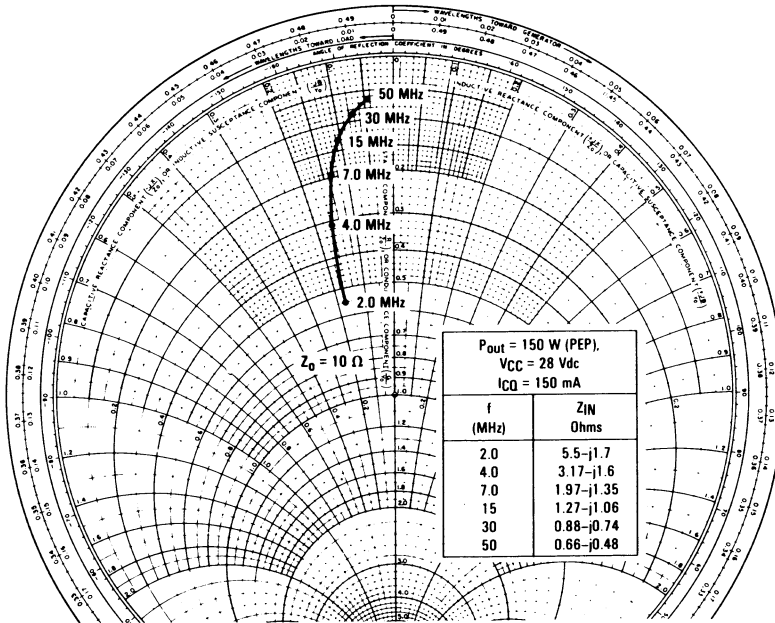


FIGURE 10 — SERIES EQUIVALENT INPUT IMPEDANCE



4.1

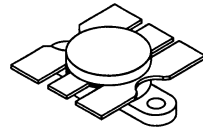
The RF Line
NPN Silicon
RF Power Transistor

... designed for 12.5 Volt UHF large-signal amplifier applications in industrial and commercial FM equipment operating to 520 MHz.

- Guaranteed 440, 470, 512 MHz 12.5 Volt Characteristics
 Output Power = 50 Watts
 Minimum Gain = 5.2 dB @ 440, 470 MHz
 Efficiency = 55% @ 440, 470 MHz
 IRL = 10 dB
- Characterized with Series Equivalent Large-Signal Impedance Parameters from 400 to 520 MHz
- Built-In Matching Network for Broadband Operation
- Triple Ion Implanted for More Consistent Characteristics
- Implanted Emitter Ballast Resistors
- Silicon Nitride Passivated
- 100% Tested for Load Mismatch Stress at all Phase Angles with 20:1 VSWR @ 15.5 Vdc, 2.0 dB Overdrive

MRF650

50 W, 512 MHz
RF POWER
TRANSISTOR
NPN SILICON



CASE 316-01, STYLE 1

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector-Emitter Voltage	V _{CEO}	16.5	Vdc
Collector-Emitter Voltage	V _{CES}	38	Vdc
Emitter-Base Voltage	V _{EBO}	4.0	Vdc
Collector Current — Continuous	I _C	12	Adc
Total Device Dissipation @ T _C = 25°C Derate above 25°C	P _D	135 0.77	Watts W/°C
Storage Temperature Range	T _{stg}	-65 to +150	°C

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case	R _{θJC}	1.3	°C/W

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted.)

Characteristic	Symbol	Min	Typ	Max	Unit
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OFF CHARACTERISTICS

Collector-Emitter Breakdown Voltage (I _C = 50 mA _{dc} , I _B = 0)	V _{(BR)CEO}	16.5	—	—	Vdc
Collector-Emitter Breakdown Voltage (I _C = 50 mA _{dc} , V _{BE} = 0)	V _{(BR)CES}	38	—	—	Vdc
Emitter-Base Breakdown Voltage (I _E = 10 mA _{dc} , I _C = 0)	V _{(BR)EBO}	4.0	—	—	Vdc
Collector Cutoff Current (V _{CE} = 15 Vdc, V _{BE} = 0, T _C = 25°C)	I _{CES}	—	—	5.0	mA _{dc}

ON CHARACTERISTICS

DC Current Gain (I _C = 5.0 Adc, V _{CE} = 5.0 Vdc)	h _{FE}	20	70	120	—
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DYNAMIC CHARACTERISTICS

Output Capacitance (V _{CB} = 12.5 Vdc, I _E = 0, f = 1.0 MHz)	C _{ob}	—	135	170	pF
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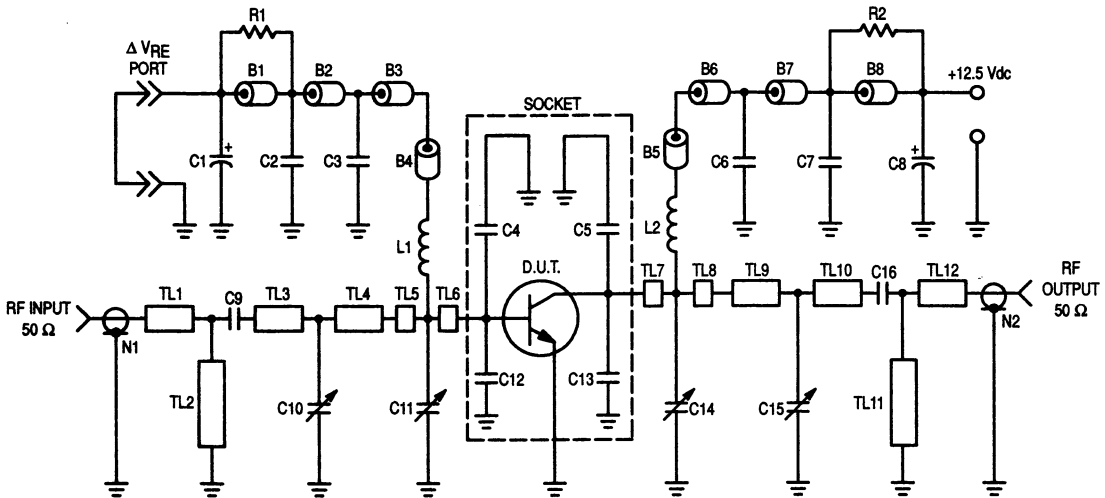
(continued)

ELECTRICAL CHARACTERISTICS — continued ($T_C = 25^\circ\text{C}$ unless otherwise noted.)

Characteristic	Symbol	Min	Typ	Max	Unit
FUNCTIONAL TESTS (In Motorola Test Fixture. See Figure 1.)					
Common-Emitter Amplifier Power Gain ($V_{CC} = 12.5\text{ Vdc}$, $P_{out} = 50\text{ W}$, $f = 440, 470\text{ MHz}$)	G_{pe}	5.2	6.1	—	dB
Common-Emitter Amplifier Power Gain ($V_{CC} = 12.5\text{ Vdc}$, $P_{out} = 50\text{ W}$, $f = 512\text{ MHz}$)	G_{pe}	5.0	5.9	—	dB
Input Return Loss ($V_{CC} = 12.5\text{ Vdc}$, $P_{out} = 50\text{ W}$, $f = 440, 470, 512\text{ MHz}$)	IRL	10	15	—	dB
Collector Efficiency ($V_{CC} = 12.5\text{ Vdc}$, $P_{out} = 50\text{ W}$, $f = 440, 470\text{ MHz}$)	η	55	65	—	%
Collector Efficiency ($V_{CC} = 12.5\text{ Vdc}$, $P_{out} = 50\text{ W}$, $f = 512\text{ MHz}$)	—	50	60	—	%
Output Mismatch Stress ($V_{CC} = 15.5\text{ V}$, 2.0 dB Overdrive, $f = 470\text{ MHz}$, VSWR = 20:1, All Phase Angles) (1)	ψ (2)	No Degradation in Output Power			

NOTES:

- $P_{in} = 2.0\text{ dB}$ above drive requirement for 50 W output at 12.5 Vdc.
- ψ = Mismatch stress factor — the electrical criterion established to verify the device resistance to load mismatch failure. The mismatch stress test is accomplished in the standard test fixture (Figure 1) terminated in a 20:1 minimum load mismatch at all phase angles.



- B1, B8 — Ferrite Bead Ferroxcube VK200 20-4B
- B2, B3, B4, B5, B6, B7 — Ferrite Bead Ferroxcube #56-590-3B
- C1, C8 — 10 μF , 25 V, 25%, Electrolytic, ECS TE-1204
- C2, C7 — 1000 pF, Chip Cap, 5%, ATC 100B102JC50
- C3, C6 — 91 pF, 5%, Mica, SAHA 3HS0006-91
- C4, C5, C12, C13 — 36 pF, 5%, SAHA 3HS0006-36
- C9, C16 — 220 pF, Chip Cap, 5%, ATC 100B221JC200
- C10, C11, C15 — 0.8–10 pF, Variable, Johanson JMC501 PG26J200
- C14 — 1.0–20 pF, Variable, Johanson JMC5501 PG26J200
- L1, L2 — 3 Turns, 18 AWG, 0.19" ID — Total Length 3.5"
- N1, N2 — N Coaxial Conn., Omni-Spectra 3052-1648-10
- R1, R2 — 10 Ohm, 10%, 1.0 W, Carbon, RCA 831010

- TL1, TL12 — $Z_0 = 50\text{ Ohm}$
- TL2 — See Photomaster
- TL3 — See Photomaster
- TL4 — See Photomaster
- TL5 — See Photomaster
- TL6 — See Photomaster
- TL7 — See Photomaster
- TL8 — See Photomaster
- TL9 — See Photomaster
- TL10 — See Photomaster
- TL11 — See Photomaster

Transmission Line Boards: 1/16" Glass-Teflon
Keene GX-0600-55-22
2 oz. Cu Clad Both Sides
 $\epsilon_r = 2.55$

Bias Boards: 1/16" G10 or Equivalent
2 oz. Cu Clad Double Sided

Figure 1. 440 to 512 MHz Broadband Test Circuit Schematic

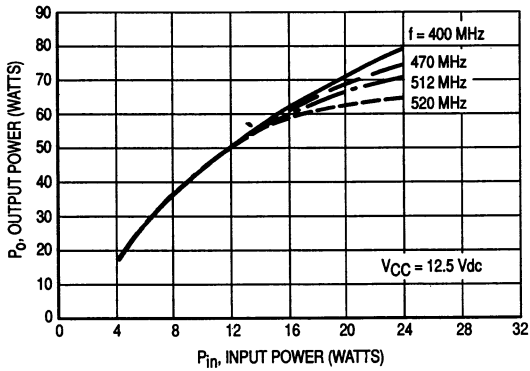


Figure 2. Output Power versus Input Power

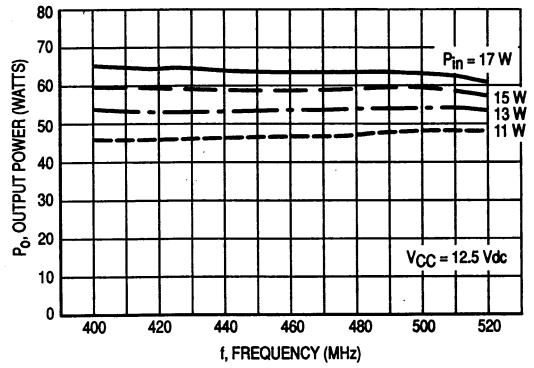


Figure 3. Output Power versus Frequency

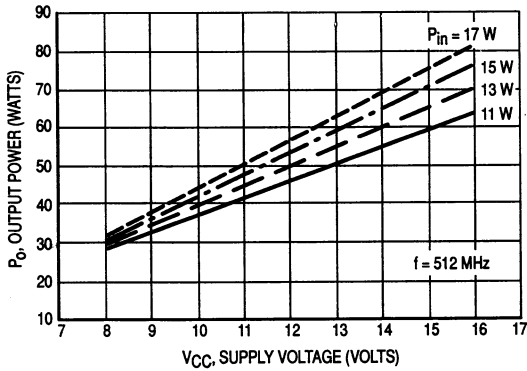


Figure 4. Output Power versus Supply Voltage

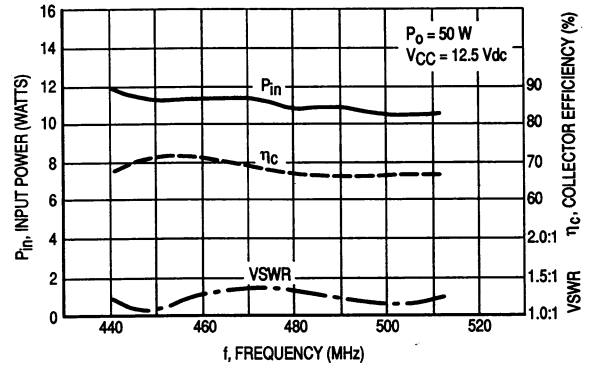
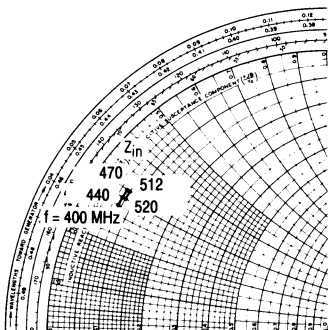


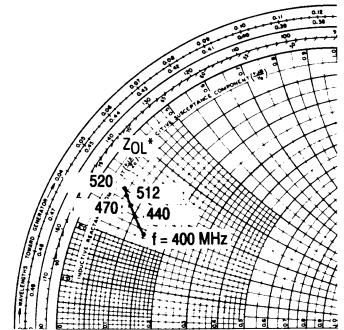
Figure 5. Broadband Performance for $P_o = 50$ W



$P_o = 50$ W, $V_{CC} = 12.5$ Vdc

TUNED FOR MAXIMUM GAIN AT $P_o = 50$ W

f (MHz)	Z_{in} Ω	Z_{OL}^* Ω
400	$0.7 + j2.8$	$1.4 + j2.3$
440	$0.7 + j3.2$	$1.1 + j2.6$
470	$0.8 + j3.3$	$0.8 + j2.7$
512	$0.8 + j3.2$	$0.7 + j2.9$
520	$0.7 + j3.0$	$0.6 + j3.0$



Z_{OL}^* = Conjugate of optimum load impedance into which the device operates at a given output power, voltage and frequency.

Figure 6. Input and Output Impedance Normalized to 10 Ohms
Circuit Tuned for Maximum Gain @ $P_o = 50$ W

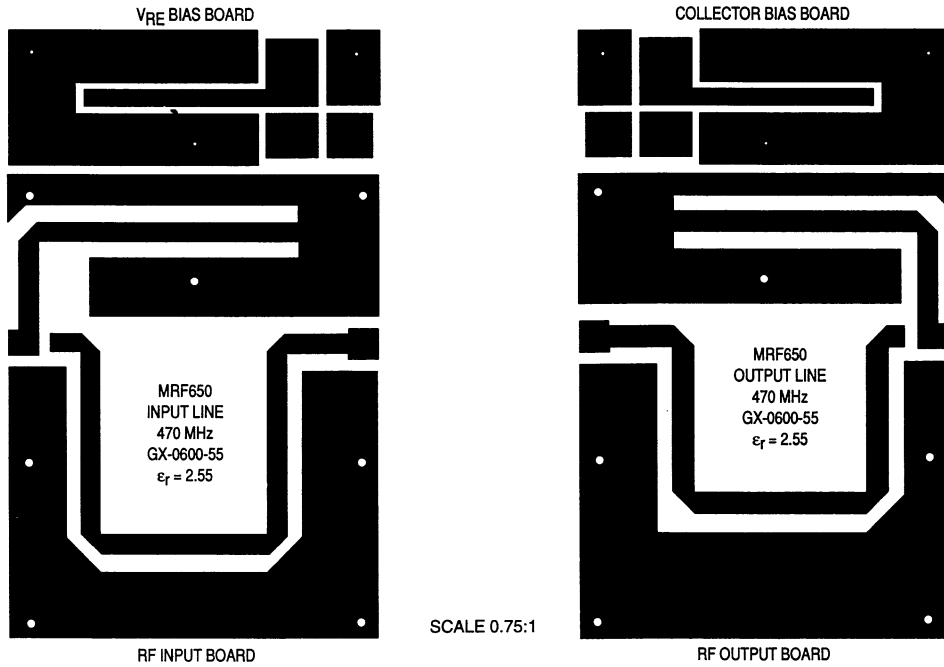


Figure 7. Photomaster for Broadband Test Circuit

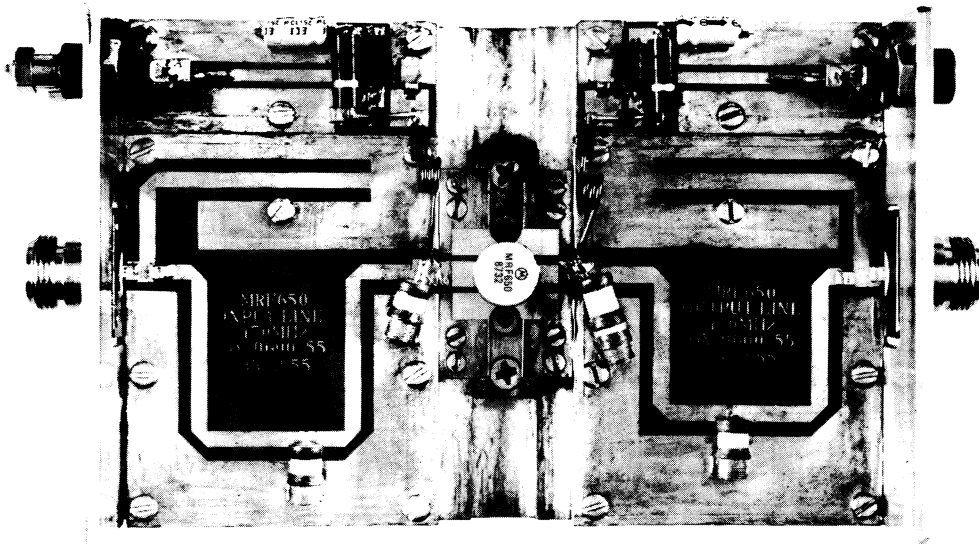
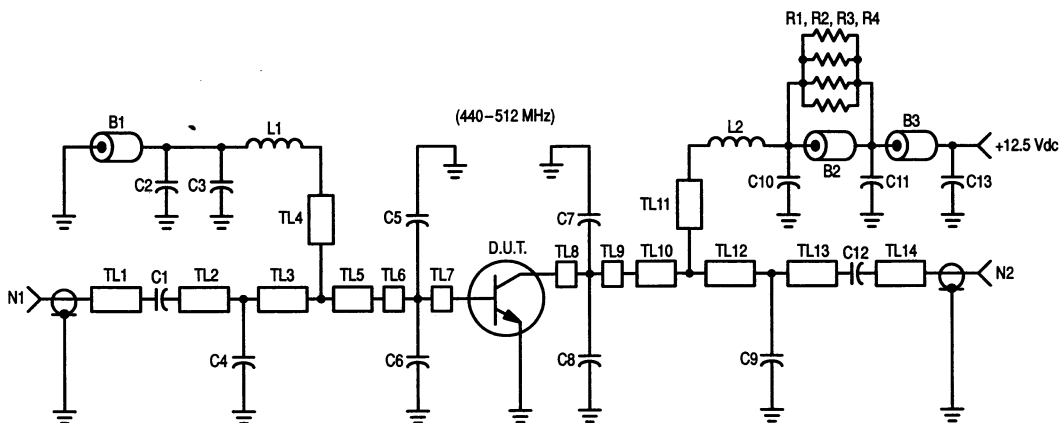


Figure 8. 440-512 MHz Broadband Test Circuit



- B1, B2 — Ferrite Bead Fair Rite Products Corp.
 B3 — Ferrite Bead Fair Rite Products Corp.
 C2, C11 — 820 pF, 5%
 C3, C10 — 91 pF, 5%, Mica, SAHA 3HS0006-91
 C1, C12 — 220 pF, 5%, Murata Erie
 C4 — 9.1 pF, 5%, Murata Erie
 C5, C6, C7, C8 — 43 pF, 5%, Mica SAHA 3HS0006-43
 C9 — 10 pF, 5%, Murata Erie
 C13 — 10 μ F, Electrolytic, 50 V, Panasonic
 L1 — 7 Turns, 24 AWG, ID Dia. 0.116"
 L2 — 5 Turns, 18 AWG, ID Dia. 0.165"
 N1, N2 — SMA Flange Mount, Omni-Spectra 2052-1618-02

- R1, R2, R3, R4 — 39 Ohm 1/8 W 5% Rohm
 TL1 — $Z_0 = 50$ Ohm
 TL2 — $Z_0 = 50$ Ohm
 TL3 — $Z_0 = 50$ Ohm
 TL4 — See Photomaster
 TL5 — $Z_0 = 50$ Ohm
 TL6 — See Photomaster
 TL7 — See Photomaster
 TL8 — See Photomaster
 TL9 — See Photomaster
 TL10 — $Z_0 = 50$ Ohm
 TL11 — See Photomaster
 TL12 — $Z_0 = 50$ Ohm
 TL13 — $Z_0 = 50$ Ohm
 TL14 — $Z_0 = 50$ Ohm
 Board Material: 1/16" G10, $\epsilon_r = 4.5$
 2 oz. Cu Clad Both Sides

Figure 9. Schematic of Broadband Demonstration Amplifier (3)

PERFORMANCE CHARACTERISTICS OF BROADBAND DEMONSTRATION AMPLIFIER

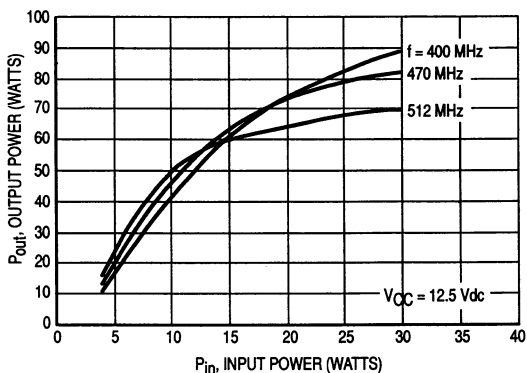


Figure 10. Output Power versus Input Power

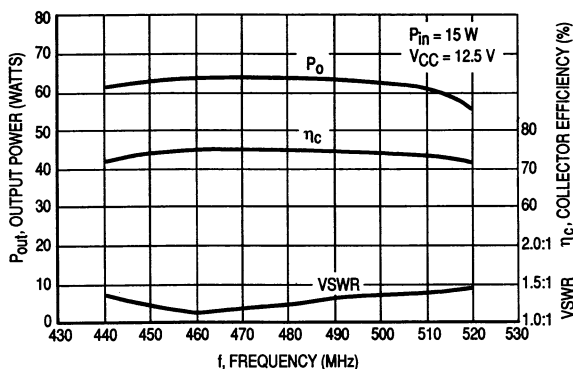


Figure 11. P_o , η_c and VSWR versus Frequency

(3) Detailed design and performance information available from Motorola upon request.

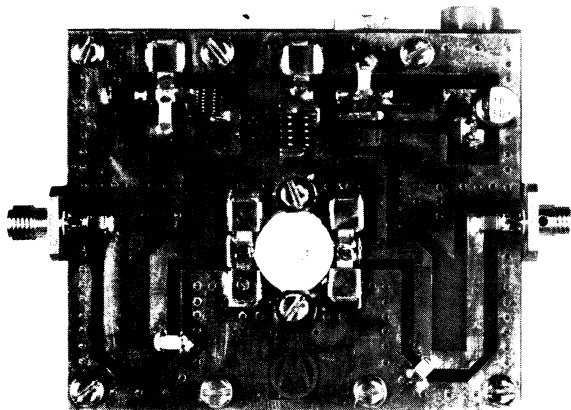
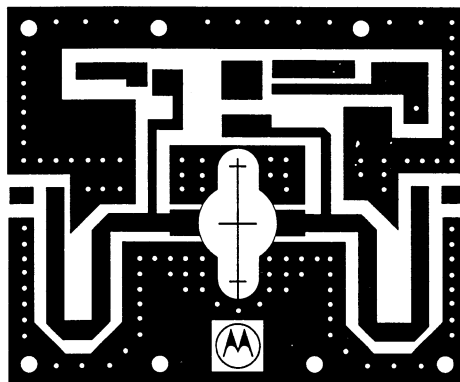


Figure 12. 440–512 MHz Broadband Demonstration Amplifier



SCALE 0.75:1

Figure 13. Photomaster for 440–512 MHz Broadband Demonstration Amplifier

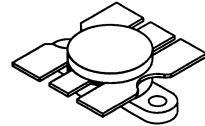
The RF Line
NPN Silicon
RF Power Transistor

Designed for 12.5 Volt UHF large-signal, common emitter, class-C amplifier applications in industrial and commercial FM equipment operating to 520 MHz.

- Specified 12.5 Volt, 512 MHz Characteristics
 Output Power = 65 Watts
 Minimum Gain = 4.15 dB
 Minimum Efficiency = 50%
- Characterized with Series Equivalent Large-Signal Impedance Parameters from 400 to 520 MHz
- Built-In Matching Network for Broadband Operation
- Triple Ion Implanted for More Consistent Characteristics
- Implanted Emitter Ballast Resistors for Improved Ruggedness
- Silicon Nitride Passivated
- Capable of Surviving Load Mismatch Stress at all Phase Angles with 20:1 VSWR @ 15.5 Vdc and 2.0 dB Overdrive

MRF658

65 W, 512 MHz
RF POWER TRANSISTOR
NPN SILICON



CASE 316-01, STYLE 1

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector-Emitter Voltage	V _{CEO}	16.5	Vdc
Collector-Emitter Voltage	V _{CES}	38	Vdc
Emitter-Base Voltage	V _{EBO}	4.0	Vdc
Collector Current — Continuous	I _C	15	Adc
Total Device Dissipation @ T _C = 25°C Derate above 25°C	P _D	175 1.0	Watts W/°C
Storage Temperature Range	T _{stg}	- 65 to +150	°C

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case	R _{θJC}	1.0	°C/W

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted.)

Characteristic	Symbol	Min	Typ	Max	Unit
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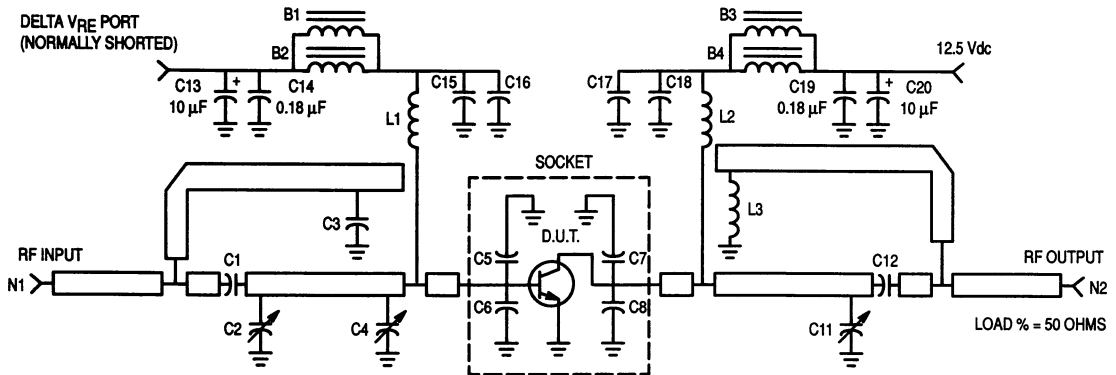
OFF CHARACTERISTICS

Collector-Emitter Breakdown Voltage (I _C = 50 mAdc, I _B = 0)	V _{(BR)CEO}	16.5	29	—	Vdc
Collector-Emitter Breakdown Voltage (I _C = 50 mAdc, V _{BE} = 0)	V _{(BR)CES}	38	45	—	Vdc
Emitter-Base Breakdown Voltage (I _E = 10 mAdc, I _C = 0)	V _{(BR)EBO}	4.0	4.6	—	Vdc
Collector Cutoff Current (V _{CE} = 15 Vdc, V _{BE} = 0, T _C = 25°C)	I _{CES}	—	0.1	10	mAdc

(continued)

ELECTRICAL CHARACTERISTICS — continued ($T_C = 25^\circ\text{C}$ unless otherwise noted.)

Characteristic	Symbol	Min	Typ	Max	Unit
ON CHARACTERISTICS					
DC Current Gain ($I_C = 10 \text{ A dc}$, $V_{CE} = 5.0 \text{ V dc}$)	h_{FE}	40	85	120	—
DYNAMIC CHARACTERISTICS					
Output Capacitance ($V_{CB} = 12.5 \text{ V dc}$, $I_E = 0$, $f = 1.0 \text{ MHz}$)	C_{ob}	—	170	220	pF
FUNCTIONAL TESTS (In Motorola Test Fixture. See Figure 1.)					
Output Power ($V_{CC} = 12.5 \text{ V dc}$, $P_{in} = 25 \text{ W}$, $f = 470 \text{ \& } 512 \text{ MHz}$)	P_{out}	65	—	—	W
Collector Efficiency ($V_{CC} = 12.5 \text{ V dc}$, $P_{out} = 65 \text{ W}$, $f = 470 \text{ \& } 512 \text{ MHz}$)	η	50	60	—	%
Output Mismatch Stress ($V_{CC} = 15.5 \text{ V dc}$, $P_{in} = 32 \text{ W}$, $f = 512 \text{ MHz}$, VSWR 20:1, All Phase Angles)	ψ	No Degradation in Output Power			
Input Return Loss ($P_O = 65 \text{ W}$, $f = 470 \text{ \& } 512 \text{ MHz}$, $V_{CC} = 12.5 \text{ V}$)	IRL	10	15	—	dB



- B1-B4 — Long Bead, Fair Rite (2743019446)
- C1 — 56 pF, Chip Capacitor, Murata Erie
- C2 — 1-20 pF Trimmer, Johanson-JMC 5501 PG26J200
- C3 — 39 pF, Chip Capacitor, Murata Erie
- C4 — 1-20 pF Trimmer, Johanson-JMC 5501
- C5 — 33 pF, Miniature Clamped Mica, SAHA
- C6 — 33 pF, Miniature Clamped Mica, SAHA
- C7 — 33 pF, Miniature Clamped Mica, SAHA
- C8 — 27 pF, Miniature Clamped Mica, SAHA
- C11 — 1-20 pF Trimmer, Johanson-JMC 5501 PG26J200
- C12 — 110 pF, Chip Capacitor, Murata Erie
- C13 — 10 μF , 50 V Electrolytic, Panasonic-ECEV1HV100R
- C14 — 0.18 μF Chip Capacitor
- C15 — 130 pF, Chip Capacitor, Murata Erie

- C16 — 130 pF, Chip Capacitor, Murata Erie
- C17 — 130 pF, Chip Capacitor, Murata Erie
- C18 — 130 pF, Chip Capacitor, Murata Erie
- C19 — 0.18 μF Chip Capacitor
- C20 — 10 μF , 50 V Electrolytic, Panasonic-ECEV1HV100R
- Board — 1/16" Glass Teflon, $\epsilon_r = 2.55$, Keene (GX-0600-55-22)
- L1, L2 — 5 Turns, 20 AWG, ID 0.126"
- L3 — 2 Turns, 26 AWG, ID 0.073"
- N1, N2 — Type N Flange, Omni Spectra (3052-1648-10)

- Murata Erie Chip Capacitors — GRH710COGxxxx100VBE
- SAHA Mini Clamped Mica Capacitors — 3HS0006-xx

Figure 1. 512 MHz Test Circuit

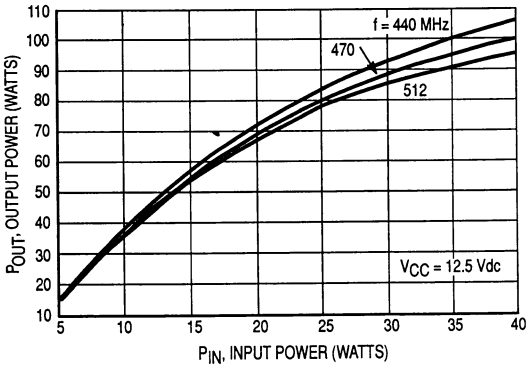


Figure 2. Output Power versus Input Power

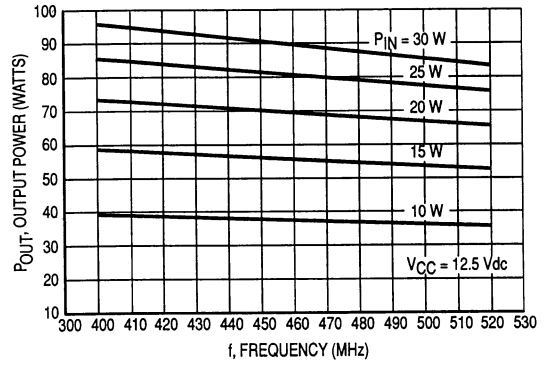


Figure 3. Output Power versus Frequency

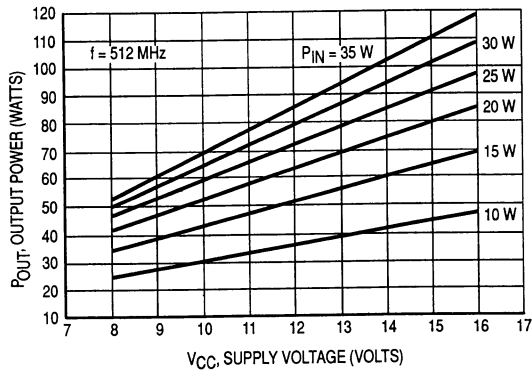
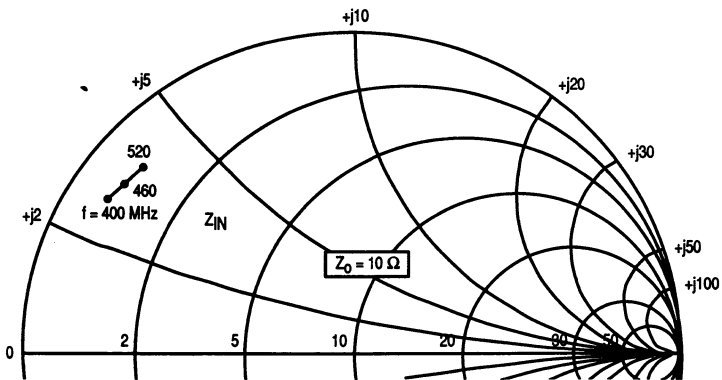
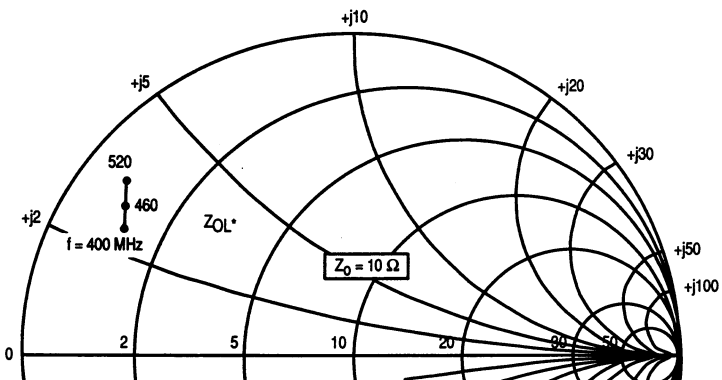


Figure 4. Output Power versus Supply Voltage



$V_{CC} = 12.5 \text{ V}$ $P_o = 70 \text{ W}$

f MHz	Z_{IN} OHMS	Z_{OL}^* OHMS
400	$0.62 + j2.8$	$1.20 + j2.5$
440	$0.72 + j3.1$	$1.10 + j2.8$
480	$0.81 + j3.3$	$0.94 + j3.1$
520	$0.90 + j3.6$	$0.80 + j3.4$



Z_{OL}^* = Conjugate of optimum load impedance into which the device operates at a given output power, voltage and frequency.

Figure 5. Series Equivalent Input and Output Impedances

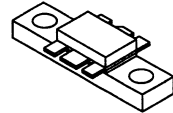
The RF Line
NPN Silicon
RF Power Transistor

... designed for 12.5 volt UHF large-signal, **common-base** amplifier applications in industrial and commercial FM equipment operating in the range of 806–960 MHz.

- Specified 12.5 Volt, 870 MHz Characteristics
 Output Power = 45 Watts
 Power Gain = 4.5 dB Min
 Efficiency = 60% Min
- Series Equivalent Large-Signal Characterization
- Internally Matched Input for Broadband Operation
- Tested for Load Mismatch Stress at All Phase Angles with 10:1 VSWR @ High Line and Rated Drive
- Gold Metallized, Emitter Ballasted for Long Life and Resistance to Metal Migration
- Silicon Nitride Passivated

MRF847

45 W, 870 MHz
RF POWER
TRANSISTOR
NPN SILICON



CASE 319, STYLE 1

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector-Emitter Voltage	V_{CEO}	16.5	Vdc
Collector-Base Voltage	V_{CBO}	38	Vdc
Emitter-Base Voltage	V_{EBO}	4.0	Vdc
Collector Current — Continuous	I_C	12	Adc
Total Device Dissipation @ $T_A = 25^\circ\text{C}$ Derate above 25°C	P_D	150 0.85	Watts W/ $^\circ\text{C}$
Storage Temperature Range	T_{stg}	-65 to +150	$^\circ\text{C}$
Junction Temperature	T_J	200	$^\circ\text{C}$

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case	$R_{\theta JC}$	1.17	$^\circ\text{C/W}$

ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$ unless otherwise noted.)

Characteristic	Symbol	Min	Typ	Max	Unit
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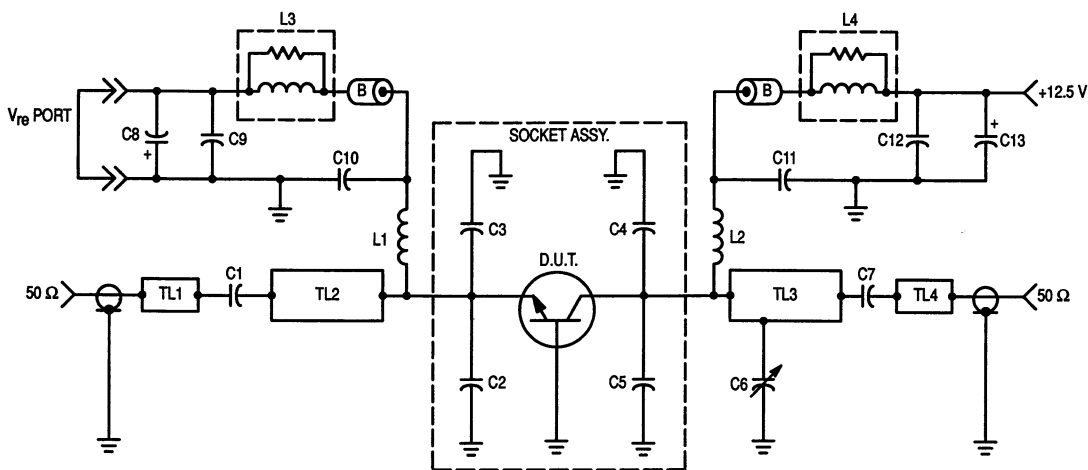
OFF CHARACTERISTICS

Emitter-Base Breakdown Voltage ($I_E = 5.0 \text{ mAdc}$, $I_C = 0$)	$V_{(BR)EBO}$	4.0	—	—	Vdc
Collector-Emitter Breakdown Voltage ($I_C = 50 \text{ mAdc}$, $I_B = 0$)	$V_{(BR)CEO}$	16.5	—	—	Vdc
Collector-Emitter Breakdown Voltage ($I_C = 50 \text{ mAdc}$, $V_{BE} = 0$)	$V_{(BR)CES}$	38	—	—	Vdc
Collector Cutoff Current ($V_{CE} = 15 \text{ Vdc}$, $V_{BE} = 0$)	I_{CES}	—	—	10	mAdc

(continued)

ELECTRICAL CHARACTERISTICS — continued ($T_C = 25^\circ\text{C}$ unless otherwise noted.)

Characteristic	Symbol	Min	Typ	Max	Unit
ON CHARACTERISTICS					
DC Current Gain ($I_C = 2.0 \text{ Adc}$, $V_{CE} = 5.0 \text{ Vdc}$)	h_{FE}	40	65	120	—
DYNAMIC CHARACTERISTICS					
Output Capacitance ($V_{CB} = 12.5 \text{ Vdc}$, $I_E = 0$, $f = 1.0 \text{ MHz}$)	C_{ob}	—	75	90	pF
FUNCTIONAL TESTS					
Common-Base Amplifier Power Gain ($V_{CC} = 12.5 \text{ Vdc}$, $P_{out} = 45 \text{ W}$, $f = 870 \text{ MHz}$)	G_{PB}	4.5	5.5	—	dB
Collector Efficiency ($V_{CC} = 12.5 \text{ Vdc}$, $P_{out} = 45 \text{ W}$, $f = 870 \text{ MHz}$)	η_c	60	68	—	%
Load Mismatch ($V_{CC} = 15.5 \text{ Vdc}$, $P_{in} = 16 \text{ W}$, $f = 870 \text{ MHz}$, $VSWR = 10:1$, All Phase Angles)	ψ	No Degradation in Output Power			



- C1 — 51 pF, 100 mil Chip Capacitor
- C2 — 12 pF, Mini-Underwood
- C3 — 11 pF, Mini-Underwood
- C4, C5 — 21 pF, Mini-Underwood
- C6 — 0.08–8.0 pF Johansen Gigatrim
- C7 — 47 pF, 100 mil Chip Capacitor
- C8, C13 — 10 μF , 25 WV Electrolytic Capacitor
- C9, C12 — 1000 pF Unelco J101

- C10, C11 — 91 pF Mini-Underwood
- L1, L2 — 4 Turns #18 Enameled, 200 mil ID
- L3, L4 — 12 Turns #22 Enameled, Wound Over 10 Ω Resistor
- TL1, TL4 — 50 Ω Microstrip Line
- TL2 — Microstrip ($Z_0 = 38 \text{ ohms}$, $\lambda/4 @ 838 \text{ MHz}$)
- TL3 — Microstrip ($Z_0 = 28 \text{ ohms}$, $\lambda/4 @ 838 \text{ MHz}$)
- Board Material — 0.032" Glass-Teflon, 2 oz. cu. clad, $\epsilon_r = 2.56$
- B — Ferrite Bead, Ferroxcube 56-590-65-3B

Figure 1. 806–870 MHz Broadband Test Circuit

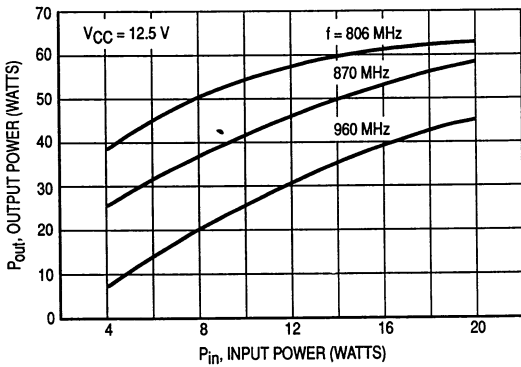


Figure 2. Output Power versus Input Power

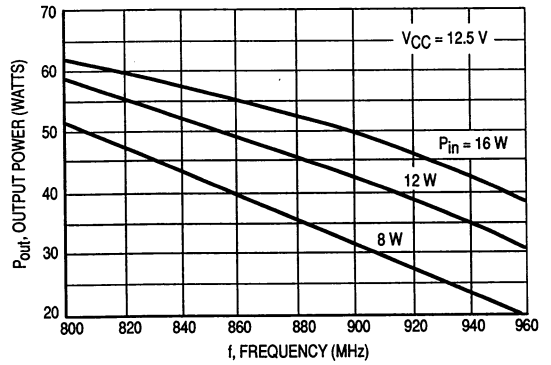


Figure 3. Output Power versus Frequency

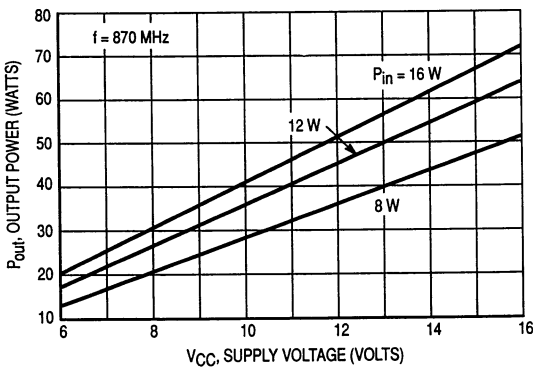


Figure 4. Output Power versus Supply Voltage

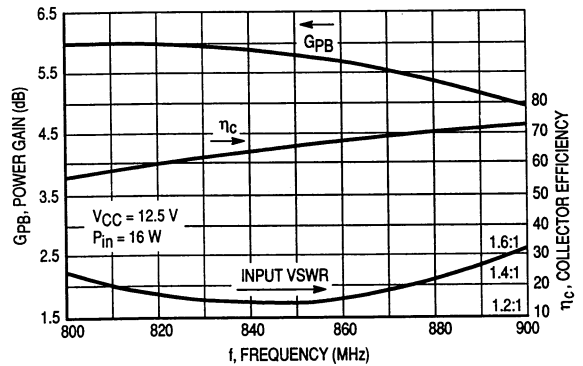
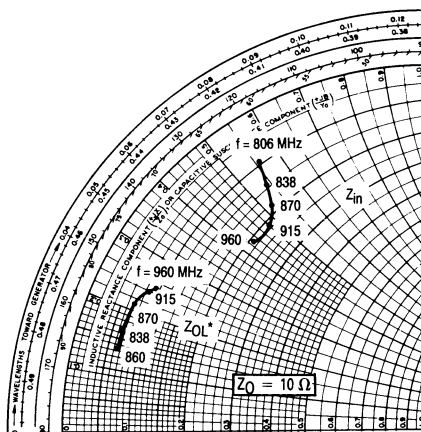


Figure 5. Typical Broadband Circuit Performance



$V_{CC} = 12.5 \text{ Vdc}$, $P_{in} = 16 \text{ W}$, $P_{out} = 45 \text{ W}$

f MHz	Z_{in} (Ohms)	f MHz	Z_{OL}^* (Ohms)
806	0.99 + j5.52	806	0.67 + j1.33
838	1.48 + j5.47	838	0.68 + j1.66
870	1.79 + j5.25	870	0.72 + j2.16
915	2.12 + j4.80	915	0.83 + j2.40
960	2.11 + j4.28	960	0.99 + j2.50

Z_{OL}^* = Conjugate of the optimum load impedance into which the device output operates at a given output power, voltage, and frequency.

Figure 6. Series Equivalent Input/Output Impedances